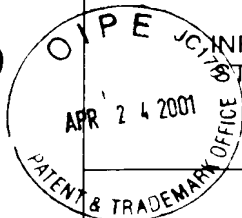


FORM PTO-1449 (SUBSTITUTE)

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PATENT AND TRADEMARK OFFICEAttorney Docket No.:
GR 99 P 5374Applic. No.
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Applicant

Nicolas Nagel et al.

Filing Date
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2812INFORMATION DISCLOSURE
STATEMENT BY APPLICANT
(37 CFR 1.98(b))

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EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
DV	A	5,182,231	01/26/93	Hongo et al.			
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	C	5,392,189	02/21/95	Fazan et al.			
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DV	F	5,892,254	04/06/99	Park et al.			
	G						
	H						
	I						

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		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES	NO
DV	J	42 07 916 A1	10/15/92	Germany				
	K	0 307 272 A2	03/15/89	Europe			X	
	L	0 735 586 A2	10/02/96	Europe			X	
DV	M	0 867 941 A2	09/30/98	Europe			X	
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O	Ming Shiahn Tsai et al.: "Effect of Bottom Electrode Materials on the Electrical and Reliability Characteristics of (Ba, Sr) TiO ₃ Capacitors", IEEE Transactions on Electron Devices, Vol. 46, No. 9, September 1999, pp. 1829-1838
P	

EXAMINER

Frederick

DATE CONSIDERED

03/05/02

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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